

SSF60R850S-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	600				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.85			
Q _g (Max.) (nC)	15				
Q _{gs} (nC)	3				
Q _{gd} (nC)	6				
Configuration	Single				

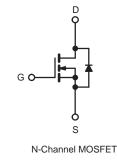
FEATURES

- Low Gate Charge Q_{g} Results in Simple Drive Requirement



- RoHS · Improved Gate, Avalanche and Dynamic dV/dt COMPLIANT Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- · Compliant to RoHS directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	600	V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current ^e	V _{GS} at 10 V	T _C = 25 °C		5		
Continuous Drain Current	V _{GS} at 10 V	$T_C = 100 ^{\circ}C$	ID	4	А	
Pulsed Drain Current ^a			I _{DM}	16		
Linear Derating Factor				1.67/0.8/0.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	120	mJ	
Repetitive Avalanche Current ^a			I _{AR}	34	А	
Repetitive Avalanche Energy ^a			E _{AR}	17	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	205/35/30	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) ^d	for 10 s			300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N·m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 24 mH, R_G = 25 Ω , I_{AS} = 3.2 A (see fig. 12). c. I_{SD} \leq 3.2 A, dl/dt \leq 90 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.

d. 1.6 mm from case.

e. Drain current limited by maximum junction temperature.



PARAMETER	SYMBOL	TYP		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		62				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6/1.2/0.6		6	°C/W			
	unloss other	vice noted						
SPECIFICATIONS $T_J = 25 \text{ °C}$, PARAMETER	SYMBOL				MIN.	TYP.	MAX.	UNIT
Static	STWBOL				IVIIIN.		WIAA.	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		600	-	-	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, $I_D = 1 \text{ mA}^d$		-	0.6	-	mV/°	
Gate-Source Threshold Voltage	V _{GS(th)}		$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	-	$V_{GS} = \pm 30 \text{ V}$		-	-	± 100	nA
			$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	10	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 520 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$		-	-	100	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D =	= 2.5 A ^b	-	0.85	-	Ω
Forward Transconductance	g _{fs}	V _{DS} :	= 50 V, I _D =	2.5 A	8	-	-	S
Dynamic						•		•
Input Capacitance	Ciss	V _{GS} = 0 V,		-	320	-		
Output Capacitance	C _{oss}		$V_{DS} = 25 V,$		-	75	-	1
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	4	-	~=	
Output Canacitance	C _{oss}		V _{DS} = 1.0	V, f = 1.0 MHz	-	500	-	- pF
Output Capacitance		$V_{GS} = 0 V$	$V_{DS} = 520$	V, f = 1.0 MHz	-	83	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 V \text{ to } 520 V^{c}$		-	14	-]
Total Gate Charge	Qg				-	-	15	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 2.5 \text{ A}, V_{DS} = 400 \text{ V}$		-	-	3	nC
Gate-Drain Charge	Q _{gd}	see fig. 6 a		. 6 and 13 ^b	-	-	6	
Turn-On Delay Time	t _{d(on)}		•		-	18	-	
Rise Time	t _r		= 325 V, I _D =		-	40	-	
Turn-Off Delay Time	t _{d(off)}	$\label{eq:RG} \begin{array}{l} R_{G} = 9.1 \; \Omega, \; R_{D} = 62 \; \Omega, \\ \text{see fig. 10}^{\text{b}} \end{array}$		-	50	-	- ns	
Fall Time	t _f			-	30	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	۱ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	16		
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 3.2 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 3.2 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$		-	180	-	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	3.2	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	Irn-on time is	s negligible (turn	on is dor	ninated by	y L _S and	L _D)

Notes

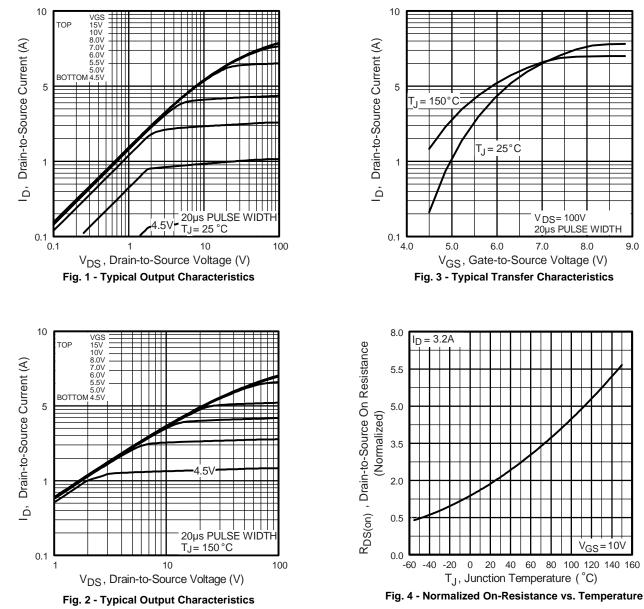
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .

d. t = 60 s, f = 60 Hz.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

SSF60R850S-VB



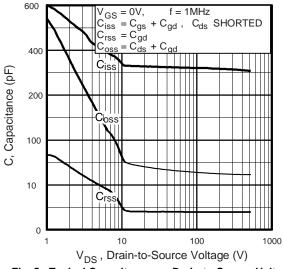


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

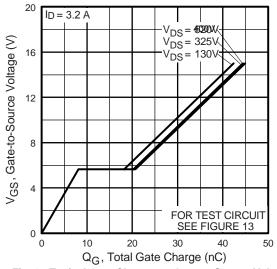


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

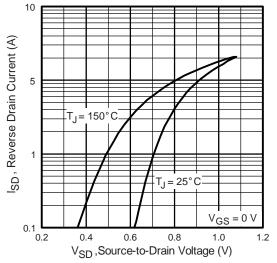
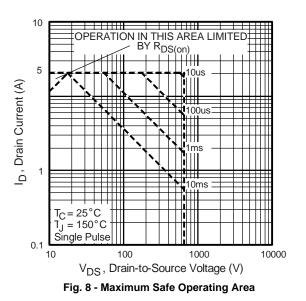


Fig. 7 - Typical Source-Drain Diode Forward Voltage





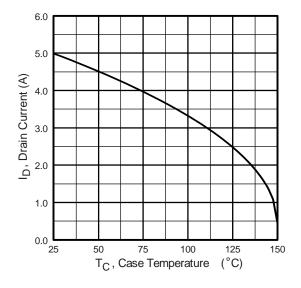


Fig. 9 - Maximum Drain Current vs. Case Temperature

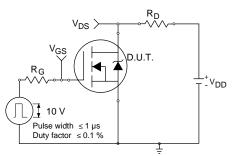


Fig. 10a - Switching Time Test Circuit

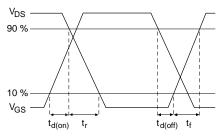
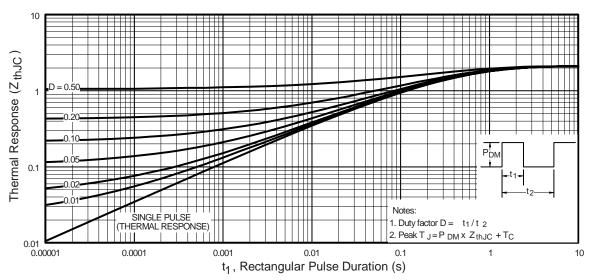
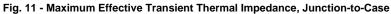


Fig. 10b - Switching Time Waveforms





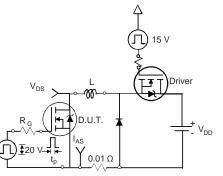
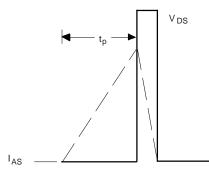
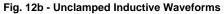


Fig. 12a - Unclamped Inductive Test Circuit





SSF60R850S-VB



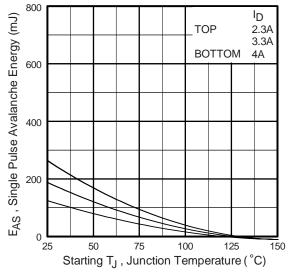


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

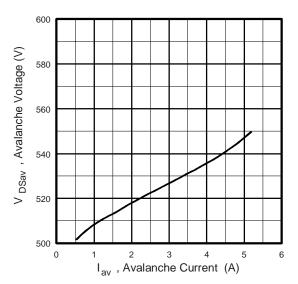


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

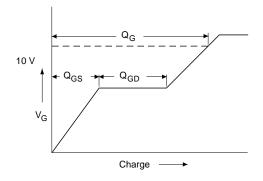


Fig. 13a - Basic Gate Charge Waveform

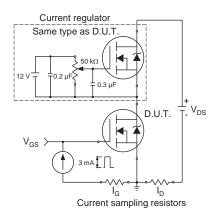
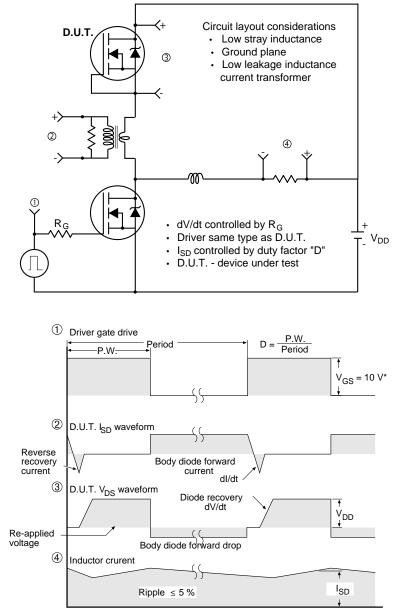


Fig. 13b - Gate Charge Test Circuit





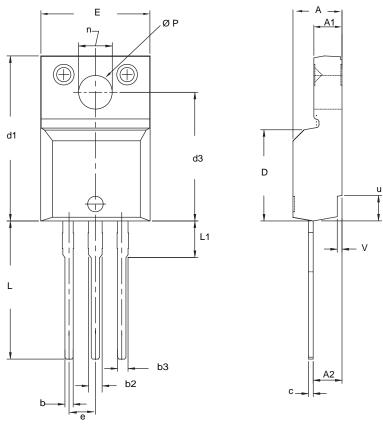
Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
A	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
C	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	
ECN: X09-0126-Rev. B, 20 DWG: 5972	6-Oct-09				

Notes

Notes 1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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